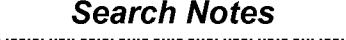


| Search Notes<br> | Application/Control No. | Applicant(s)/Patent under Reexamination |  |
|--|-------------------------|---|--|
|  | 10/566,116              | INOUE ET AL.                            |  |
| Examiner   | WEIPING ZHU             | Art Unit<br>1793                        |  |
|  |                         |   |  |

## **Search Notes**



**Application/Control No.**

10/566,116

## **Examiner**

WEIPING ZHU

**Applicant(s)/Patent under  
Reexamination**

INOUE ET AL.

## **Art Unit**

1793

## **INTERFERENCE SEARCHED**

| Class | Subclass | Date | Examiner |
|-------|----------|------|----------|
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## **SEARCH NOTES (INCLUDING SEARCH STRATEGY)**